## Issue Classification | 10573646



12 10 12 ORIGINAL

Application/Control No.	

Examiner Α DEREK S CHAPEL

Applicant(s)/Patent Under Reexamination	
MIZUSHIMA ET AL.	

MIZUSHIMA ET AL.	
Art Unit	
2872	

INTERNATIONAL CLASSIFICATION

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	(Assistant Examiner) (Date)															
/Arnel C Lavarias/ Primary Examiner		372						07/30	V2010	0.0	O.G. Print Claim(s) O.G. Pr					
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